'LS668 . . . SYNCHRONOUS UP/DOWN DECADE COUNTERS 'LS669 . . . SYNCHRONOUS UP/DOWN BINARY COUNTERS

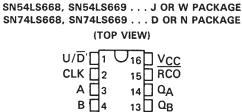
Programmable Look-Ahead Up/Down Binary/Decade Counters

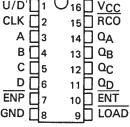
- Fully Synchronous Operation for Counting and Programming
- Internal Look-Ahead for Fast Counting
- Carry Output for n-Bit Cascading
- Fully Independent Clock Circuit
- Buffered Outputs

TYPE		TYPICAL MAXIMUM CLOCK FREQUENCY				
TYPE	COUNTING	COUNTING COUNTING				
	UP	DOWN	DISSIPATION			
'LS 668, 'LS 669	32 MHz	32 MHz	100 mW			

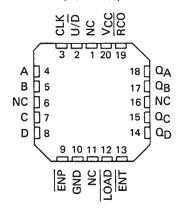
description

These synchronous presettable counters feature an internal carry look-ahead for cascading in high-speed counting applications. The 'LS668 are decade counters and the 'LS669 are 4-bit binary counters. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when so instructed by the count-enable inputs and internal gating. This mode of operation helps eliminate the output counting spikes that are normally associated with asynchronous (ripple-clock) counters. A buffered clock input triggers the four master-slave flip-flops on the rising (positive-going) edge of the clock waveform.





SN54LS668, SN54LS669 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

These counters are fully programmable; that is, the outputs may each be preset to either level. The load input circuitry allows loading with the carry-enable output of cascaded counters. As loading is synchronous, setting up a low level at the load input disables the counter and causes the outputs to agree with the data inputs after the next clock pulse.

The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two count-enable inputs and a carry output. Both count enable inputs (\overline{P} and \overline{T}) must be low to count. The direction of the count is determined by the level of the up/down input. When the input is high, the counter counts up; when low, it counts down. Input \overline{T} is fed forward to enable the carry output. The carry output thus enabled will produce a low-level output pulse when the count is maximum counting up or zero counting down. This low-level overflow carry pulse can be used to enable successive cascaded stages. Transitions at the enable \overline{P} or \overline{T} inputs are allowed regardless of the level of the clock input. All inputs are diode-clamped to minimize transmission-line effects, thereby simplifying system design.

These counters feature a fully independent clock circuit. Changes at control inputs (enable P, enable T, load, up/down) that will modify the operating mode have no effect until clocking occurs. The function of the counter (whether enabled, disabled, loading, or counting) will be dictated solely by the conditions meeting the stable setup and hold times.

The 'LS668 and 'LS669 are completely new designs. Compared to the original 'LS168 and 'LS169, they feature 0-nanosecond minimum hold time, reduced input currents I_IH and I_IL, and all buffered outputs.



Pin numbers shown are for D, J, N, and W packages.

logic diagram (positive logic) SN54LS668, SN74LS668, DECADE COUNTERS CLOCK (2) (14) QA U/D (1) LOAD (9) ENABLE (7) ENABLE (10) (13)_{QB} DATA A (3) DATA B (4) (12) Q_C DATA C (5) (11)_{OD} DATA D (6) (15) RCO



logic diagram (positive logic) (continued)

SN54LS669, SN74LS669, BINARY COUNTERS CLOCK (2) (14)_{QA} U/D (1) LOAD (9) ENABLE (7) ENABLE (10) (13) QB DATA A (3) DATA B (4) (12) QC DATA C (5) (11) QD DATA D (6) (15) RCO





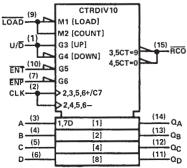
'LS668 DECADE COUNTERS

typical load, count, and inhibit sequences

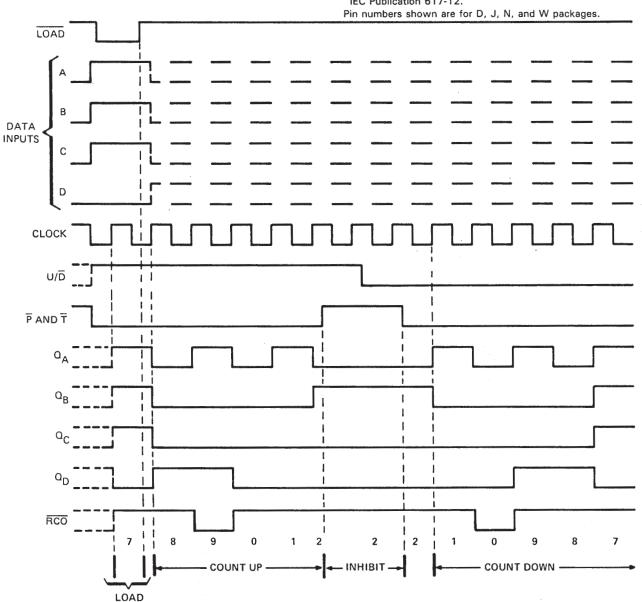
Illustrated below is the following sequence:

- 1. Load (preset) to BCD seven
- 2. Count up to eight, nine (maximum), zero, one, and two
- 3. Inhibit
- 4. Count down to one, zero (minimum), nine, eight, and seven

logic symbol†



[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.



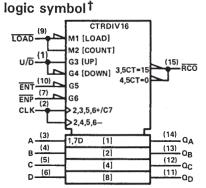


'LS669 BINARY COUNTERS

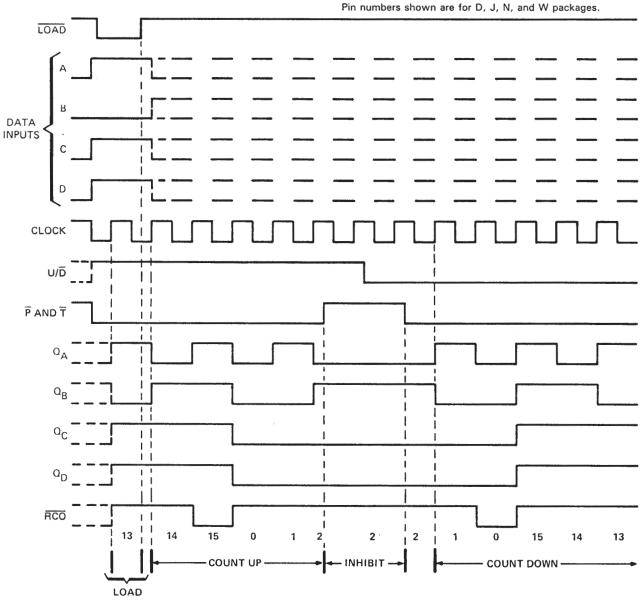
typical load, count, and inhibit sequences

Illustrated below is the following sequence:

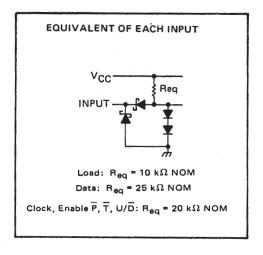
- 1. Load (preset) to binary thirteen
- 2. Count up to fourteen, fifteen (maximum), zero, one, and two
- 3. Inhibit
- 4. Count down to one, zero (minimum), fifteen, fourteen, and thirteen

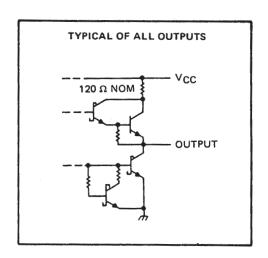


[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.



schematics of inputs and outputs





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1) .		
Input voltage		
Operating free-air temperature range:	SN54LS668, SN54LS669	9
	SN74LS668, SN74LS669) 0°C to 70°C
Storage temperature range		

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54LS668 SN74LS668 SN54LS669 SN74LS669				UNIT			
		MIN	NOM	MAX,	MIN	NOM	MAX		
Supply voltage, VCC		4.5	5	5.5	4.75	5	5.25	٧	
High-level output current, IOH				-400			-400	μА	
Low-level output current, IOL				4			8	mA	
Clock frequency, fclock		0		25	0		25	MHz	
Width of clock pulse, tw(clock) (high or low) (see	Figure 1)	20			20			ns	
	Data inputs A, B, C, D	25			25				
Setup time, t _{su} (see Figure 1)	ENP or ENT	40			40			l	
	LOAD	30			30			ns	
	U/D	45			45				
Hold time at any input with respect to clock, th	see Figure 1)	0			0			ns	
Operating free-air temperature, TA		-55		125	0		70	°C	



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS [†]		SN54LS668 SN54LS669			SN74LS668 SN74LS669			UNIT	
					MIN	TYP‡	MAX	MIN	TYP [‡]	MAX	
VIH	High-level input voltage				2			2			V
VIL	Low-level input voltage						0.7			8.0	V
VIK	Input clamp voltage		V _{CC} = MIN,	I ₁ = -18 mA			-1.5			-1.5	V
VOH High-level output voltage		V _{CC} = MIN, V _{IL} = V _{IL} max,		2.5	3.4	138	2.7	3.4		V	
VOI	Low-level output voltage		V _{CC} = MIN, V _{IH} = 2 V,	IOL = 4 mA		0.25	0.4		0.25	0.4	V
			VIL = VIL max	10L = 8 mA					0.35	0.5	
	Input current	A, B, C, D, P, U/D					0.1			0.1	
4	at maximum	Clock, T	V _{CC} = MAX,	V ₁ = 7 V			0.1			0,1	mA
	input voltage	LOAD					0.2			0.2	1
	High-level	A, B, C, D, P, U/D					20			20	
ΉΗ	input current	Clock, T	V _{CC} = MAX,	V1 = 2.7 V			20			20	μΑ
	input current	LOAD					40			40	
	Low-level	A, B, C, D, \overline{P} , U/ \overline{D}					-0.4			-0.4	
11L	input current	Clock, T	V _{CC} = MAX,	V; = 0.4 V			0.4			-0.4	mA
	mput current	LOAD					-0.8			-0.8	1
los	Short-circuit output cur	rent§	V _{CC} = MAX		-20		-100	-20		-100	mA
Icc	Supply current		V _{CC} = MAX,	See Note 2		20	34		20	34	mA

For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25°C

PARAMETER¶	FROM TO TEST CONDITIONS (INPUT)		MIN	TYP	MAX	UNIT		
f _{max}				25	32	***************************************	MHz	
^t PLH	CLK	RCO			26	40		
^t PHL	OLIK	1100	0 - 15 - 5		40	60	ns	
^t PLH	CLK	Any	C_L = 15 pF, R_L = 2 k Ω , See Figures 2 and 3		18	27		
^t PHL	CLK	a			18	27	ns	
^t PLH	ENT	RCO		See Figures 2 and 3		11	17	
^t PHL	ENI	l noo			29	45	ns	
t _{PLH} #	=	RCO			22՝	35		
t _{PHL} #	U/D	HCU			26	40	ns	

[¶] f_{max} = Maximum clock frequency.



 $^{^{\}ddagger}$ All typical values are at $V_{CC} = 5 \text{ V}$, $T_{A} = 25^{\circ}\text{C}$.

Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

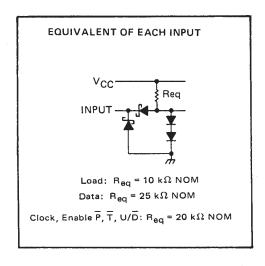
NOTE 2: 1_{CC} is measured after applying a momentary 4.5 V, then ground, to the clock input with all other inputs grounded and the outputs open.

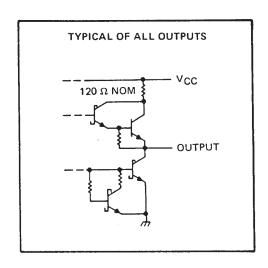
tpLH = propagation delay time, low-to-high-level output.

tpHL = propagation delay time, high-to-low-level output.

[#] Propagation delay time from up/down to ripple carry must be measured with the counter at either a minimum or a maximum count. As the logic level of the up/down input is changed, the ripple carry output will follow. If the count is minimum (0), the ripple carry output transition will be in phase. If the count is maximum (9 for 'LS668 or 15 for 'LS669), the ripple carry output will be out of phase.

schematics of inputs and outputs





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1) .		/ V
Input voltage		
Operating free-air temperature range:	SN54LS668, SN54LS669	9 —55°C to 125°C
	SN74LS668, SN74LS669	9 0°C to 70°C
Storage temperature range		

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			154LS6 154LS6		SN74LS 66 SN74LS 66			UNIT	
		MIN NOM M	MAX	MIN	NOM	MAX			
Supply voltage, VCC		4.5	5	5.5	4.75	5	5.25	٧	
High-level output current, IOH				-400			-400	μΑ	
Low-level output current, IOL				4			8	mΑ	
Clock frequency, fclock		0		25	0		25	MHz	
Width of clock pulse, tw(clock) (high or low	v) (see Figure 1)	20			20			ns	
	Data inputs A, B, C, D	25			25				
Setup time, t _{su} (see Figure 1)	ENP or ENT	40			40			ns	
Setup time, tsu (see Figure 1)	LOAD	30			30] '''	
	U/D	45			45				
Hold time at any input with respect to clo	ck, th (see Figure 1)	0			0			ns	
Operating free-air temperature, TA		-55		125	0		70	°C	



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS [†]		SN54LS668 SN54LS669			l	68 69	UNIT			
					MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX		
VIH	High-level input voltage				2			2			٧	
VIL	Low-level input voltage						0.7			0.8	V	
VIK	Input clamp voltage		V _{CC} = MIN,	I ₁ = -18 mA			-1.5			-1.5	V	
۷он	OH High-level output voltage		V _{CC} = MIN, V _{IL} = V _{IL} max,		2.5	3.4		2.7	3.4		٧	
VOL Low-level output voltage	е	V _{CC} = MIN, V _{IH} = 2 V,	IOL = 4 mA		0.25	0.4		0.25	0.4	V		
			V ₁ L = V ₁ L max	10L = 8 mA				ļ	0.00			
	Input current	A, B, C, D, P, U/D					0.1	<u> </u>		0.1		
Iţ	at maximum	Clock, T	V _{CC} = MAX,	VCC = MAX,	V ₁ = 7 V			0.1	-		0.1	mA
	input voltage	LOAD					0.2			0.2		
	High lovel	A, B, C, D, \overline{P} , U/ \overline{D}					20			20]	
IιΗ	High-level	Clock, T	V _{CC} = MAX,	$V_1 = 2.7 V$			20			20	μΑ	
	input current	LOAD]				40			40	1	
		$A, B, C, D, \overline{P}, U/\overline{D}$		•			-0.4			-0.4		
11L	Low-level	Clock, T	V _{CC} = MAX,	$V_1 = 0.4 V$			-0.4			-0.4	mA:	
	input current	LOAD					-0.8			-0.8		
los	Short-circuit output cur		V _{CC} = MAX	77.41	-20		-100	-20		-100	mA	
Icc	Supply current		VCC = MAX,	See Note 2		20	34		20	34	mA	

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25°C

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
fmax				25	32		MHz
tPLH	CLK	RCO	C _L = 15 pF,		26	40	ns
tPHL the	OLIX	1100			40	60] ""
^t PLH	CLK	Any	$R_L = 2 k\Omega$,		18	27	ns
tPHL the transfer of the trans	CLK	Q	See Figures 2 and 3		18	27	
^t PLH	ENT	RCO			11	17	ns
^t PHL	ENI	1100			29	45] ""
t _{PLH} #	=	RCO			22	35	ns
t _{PHL} #	υ/ <u>δ</u>	nco			26	40	

[¶] f_{max} = Maximum clock frequency.



 $^{^{\}ddagger}$ All typical values are at $V_{CC} = 5 \text{ V, } T_{A} = 25^{\circ}\text{C.}$

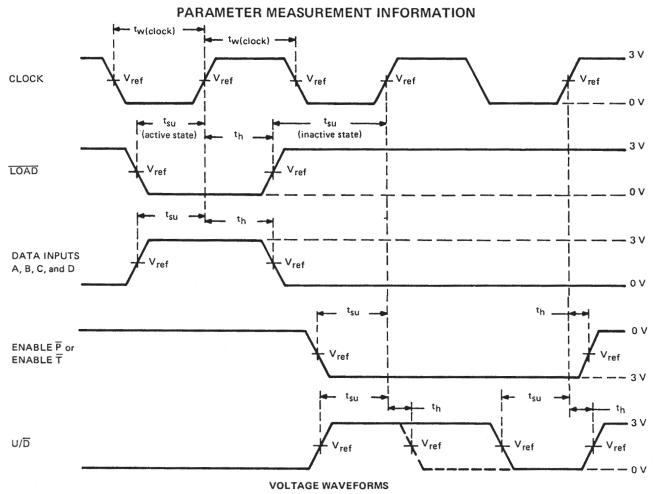
Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

NOTE 2: I_{CC} is measured after applying a momentary 4.5 V, then ground, to the clock input with all other inputs grounded and the outputs open.

tpLH = propagation delay time, low-to-high-level output.

tpHL = propagation delay time, high-to-low-level output.

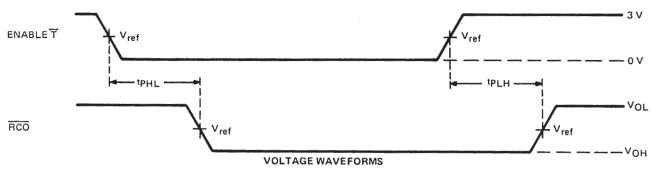
[#] Propagation delay time from up/down to ripple carry must be measured with the counter at either a minimum or a maximum count. As the logic level of the up/down input is changed, the ripple carry output will follow. If the count is minimum (0), the ripple carry output transition will be in phase. If the count is maximum (9 for 'LS668 or 15 for 'LS669), the ripple carry output will be out of phase.



NOTES: A. The input pulses are supplied by a generator having the following characteristics: PRR \leq 1 MHz, duty cycle \leq 50%, Z_{out} \approx 50 Ω ; $t_r \leq$ 15 ns, $t_f \leq$ 6 ns.

B. $V_{ref} = 1.3 V$.

FIGURE 1-PULSE WIDTHS, SETUP TIMES, HOLD TIMES



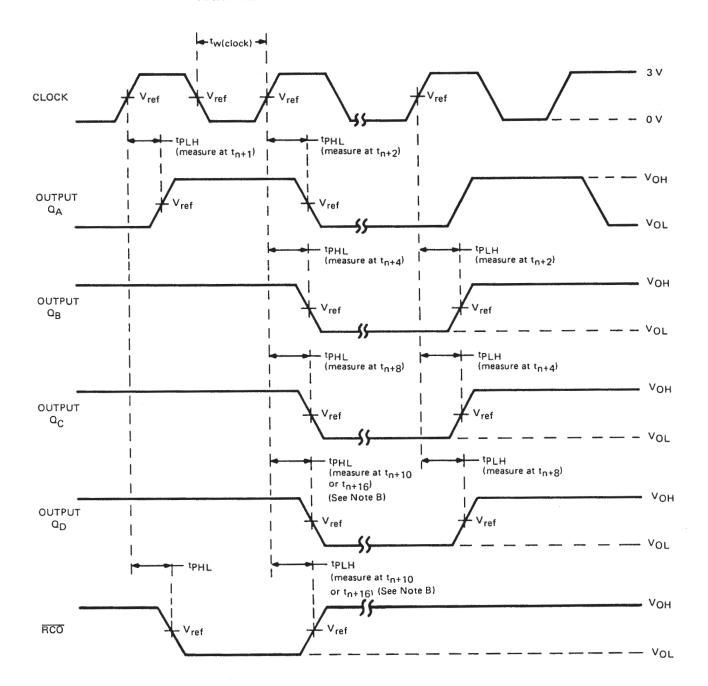
NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, duty cycle \leq 50%, Z_{out} \approx 50 Ω ; $t_r \leq$ 15 ns, $t_f \leq$ 6 ns.

- B. tp_H and tpH_ from enable T input to ripple carry output assume that the counter is at the maximum count (Q_A and Q_D high for 'LS668, all Q outputs high for 'LS669).
- C. $V_{ref} = 1.3 V$.
- D. Propagation delay time from up/down to ripple carry must be measured with the counter at either a minimum or a maximum count. As the logic level of the up/down input is changed, the ripple carry output will follow. If the count is minimum (0) the ripple carry output transition will be in phase. If the count is maximum (9 for 'LS668, or 15 for 'LS669) the ripple carry output will be out of phase.

FIGURE 2-PROPAGATION DELAY TIMES TO CARRY OUTPUT



PARAMETER MEASUREMENT INFORMATION



UP-COUNT VOLTAGE WAVEFORMS

NOTES: A. The input pulses are supplied by a generator having the following characteristics: PRR \leq 1 MHz, duty cycle \leq 50%, Z_{OUt} \approx 50 Ω , t_r \leq 15 ns, t_f \leq 6 ns. Vary PRR to measure f_{max}.

- B. Outputs Q_D and carry are tested at t_{n+10} for the 'LS668, and at t_{n+16} for the 'LS669, where t_n is the bit-time when all outputs are low.
- C. $V_{ref} = 1.3 V$.

FIGURE 3-PROPAGATION DELAY TIMES FROM CLOCK



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